## NOTES:

1. SUBSTRATE MATERIAL: **FUSED SILICA** 

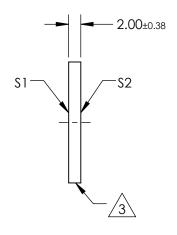
## 2. COATING (APPLY ACROSS CLEAR APERTURE)

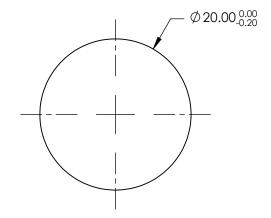
S1: R(abs)= 70% ±5% @ 350nm, 45° AOI R(avg)= 70% ±10% OVER 250 - 450nm, 45° AOI T(abs)= 30% ±5% @ 350nm, 45° AOI T(avg)= 30% ±10% OVER 250 - 450nm, 45° AOI

S2: BBAR (R(avg) <1%, R(abs) <2% OVER 250 - 450nm), 45° AOI

EDGES FINE GROUND

4. ROHS COMPLIANT





## PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

REV. A	\$1	\$2				Edmund Optic	C®
SHAPE	PLANO	PLANO					,S
CLEAR APERTURE	Ø17.00	Ø17.00		1		Ø20mm, 70R/30T, UV PLATE BEAMSPLI	TTFR
SURFACE QUALITY	60-40	60-40	THIRD ANGLE PROJECTION		TITLE	© 2011111, 70K, 301, 0 v 1 E/KIE BE/KWSI EITTEK	
SURFACE FLATNESS	1λ	1λ		1			CLIEFT
BEVEL	PROTECTED AS NEEDED	PROTECTED AS NEEDED	ALL DIMS IN	mm	DWG NO	84486	SHEET 1 OF 1